





Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,824	SHIROISHI, YOSHIHIRO	
Examiner	Art Unit	
Tianjie Chen	2656	

SEARCHED				
Class	Subclass	Date	Examiner	
360	67			
	73.03			
	77.03			
	126			
369	13.02			
428	. 141			
	822	11/22/2005	TJ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Report	11/22/2005	TJ	
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